

FINAL VERSION

VERSION FINALE



**Electromagnetic compatibility (EMC) –
Part 4-30: Testing and measurement techniques – Power quality measurement
methods**

**Compatibilité électromagnétique (CEM) –
Partie 4-30: Techniques d'essai et de mesure – Méthodes de mesure de la qualité
de l'alimentation**

CONTENTS

FOREWORD.....	7
INTRODUCTION.....	9
1 Scope.....	10
2 Normative references	10
3 Terms and definitions	11
4 General	16
4.1 Classes of measurement.....	16
4.2 Organization of the measurements.....	17
4.3 Electrical values to be measured	17
4.4 Measurement aggregation over time intervals	17
4.5 Measurement aggregation algorithm	18
4.5.1 Requirements	18
4.5.2 150/180-cycle aggregation.....	18
4.5.3 10-min aggregation.....	18
4.5.4 2-hour aggregation	20
4.6 Time-clock uncertainty	21
4.7 Flagging concept	21
5 Power quality parameters	21
5.1 Power frequency.....	21
5.1.1 Measurement method	21
5.1.2 Measurement uncertainty and measuring range	22
5.1.3 Measurement evaluation.....	22
5.1.4 Aggregation	22
5.2 Magnitude of the supply voltage.....	22
5.2.1 Measurement method	22
5.2.2 Measurement uncertainty and measuring range	22
5.2.3 Measurement evaluation.....	23
5.2.4 Aggregation.....	23
5.3 Flicker.....	23
5.3.1 Measurement method	23
5.3.2 Measurement uncertainty and measuring range	23
5.3.3 Measurement evaluation.....	23
5.3.4 Aggregation	23
5.4 Supply voltage dips and swells	24
5.4.1 Measurement method	24
5.4.2 Detection and evaluation of a voltage dip.....	24
5.4.3 Detection and evaluation of a voltage swell.....	25
5.4.4 Calculation of a sliding reference voltage.....	26
5.4.5 Measurement uncertainty and measuring range	26
5.5 Voltage interruptions.....	26
5.5.1 Measurement method	26
5.5.2 Evaluation of a voltage interruption.....	26
5.5.3 Measurement uncertainty and measuring range	27
5.5.4 Aggregation	27
5.6 Transient voltages	27

5.7	Supply voltage unbalance	27
5.7.1	Measurement method	27
5.7.2	Measurement uncertainty and measuring range	28
5.7.3	Measurement evaluation	29
5.7.4	Aggregation	29
5.8	Voltage harmonics	29
5.8.1	Measurement method	29
5.8.2	Measurement uncertainty and measuring range	29
5.8.3	Measurement evaluation	30
5.8.4	Aggregation	30
5.9	Voltage interharmonics	30
5.9.1	Measurement method	30
5.9.2	Measurement uncertainty and measuring range	30
5.9.3	Evaluation	30
5.9.4	Aggregation	30
5.10	Mains signalling voltage on the supply voltage	31
5.10.1	General	31
5.10.2	Measurement method	31
5.10.3	Measurement uncertainty and measuring range	31
5.10.4	Aggregation	31
5.11	Rapid voltage change (RVC)	31
5.11.1	General	31
5.11.2	RVC event detection	32
5.11.3	RVC event evaluation	33
5.11.4	Measurement uncertainty	34
5.12	Underdeviation and overdeviation	34
5.13	Current	34
5.13.1	General	34
5.13.2	Magnitude of current	35
5.13.3	Current recording	35
5.13.4	Harmonic currents	36
5.13.5	Interharmonic currents	36
5.13.6	Current unbalance	36
6	Performance verification	36
Annex A	(informative) Power quality measurements – Issues and guidelines	39
A.1	General	39
A.2	Installation precautions	39
A.2.1	General	39
A.2.2	Test leads	39
A.2.3	Guarding of live parts	40
A.2.4	Monitor placement	40
A.2.5	Earthing	41
A.2.6	Interference	41
A.3	Transducers	41
A.3.1	General	41
A.3.2	Signal levels	42
A.3.3	Frequency response of transducers	43
A.3.4	Transducers for measuring transients	43

A.4	Transient voltages and currents	44
A.4.1	General.....	44
A.4.2	Terms and definitions	44
A.4.3	Frequency and amplitude characteristics of a.c. mains transients	44
A.4.4	Transient voltage detection	45
A.4.5	Transient voltage evaluation	46
A.4.6	Effect of surge protective devices on transient measurements	46
A.5	Voltage dip characteristics	46
A.5.1	General.....	46
A.5.2	Rapidly updated r.m.s values	47
A.5.3	Phase angle/point-on-wave.....	47
A.5.4	Voltage dip unbalance	47
A.5.5	Phase shift during voltage dip.....	48
A.5.6	Missing voltage.....	48
A.5.7	Distortion during voltage dip	48
A.5.8	Other characteristics and references.....	48
Annex B (informative)	Power quality measurement – Guidance for applications	49
B.1	Contractual applications of power quality measurements	49
B.1.1	General.....	49
B.1.2	General considerations	49
B.1.3	Specific considerations	50
B.2	Statistical survey applications	53
B.2.1	General.....	53
B.2.2	Considerations.....	53
B.2.3	Power quality indices	54
B.2.4	Monitoring objectives	54
B.2.5	Economic aspects of power quality surveys	54
B.3	Locations and types of surveys	55
B.3.1	Monitoring locations.....	55
B.3.2	Pre-monitoring site surveys.....	56
B.3.3	Customer side site survey.....	56
B.3.4	Network side survey.....	56
B.4	Connections and quantities to measure.....	56
B.4.1	Equipment connection options	56
B.4.2	Priorities: Quantities to measure	57
B.4.3	Current monitoring	58
B.5	Selecting the monitoring thresholds and monitoring period.....	58
B.5.1	Monitoring thresholds	58
B.5.2	Monitoring period.....	58
B.6	Statistical analysis of the measured data	59
B.6.1	General.....	59
B.6.2	Indices.....	59
B.7	Trouble-shooting applications	59
B.7.1	General.....	59
B.7.2	Power quality signatures.....	59
Annex C (informative)	Conducted emissions in the 2 kHz to 150 kHz range	61
C.1	General.....	61
C.2	Measurement method – 2 kHz to 9 kHz	61

C.3	Measurement method – 9kHz to 150 kHz	62
C.4	Measurement range and measurement uncertainty	63
C.5	Aggregation	63
Annex D	(informative) Underdeviation and overdeviation	64
D.1	General.....	64
D.2	Measurement method	64
D.3	Measurement uncertainty and measuring range	64
D.4	Aggregation	64
Annex E	(informative) Class B Measurement Methods	66
E.1	Background for Class B	66
E.2	Class B – Measurement aggregation over time intervals	66
E.3	Class B – Measurement aggregation algorithm	66
E.4	Class B – Real time clock (RTC) uncertainty.....	66
E.4.1	General.....	66
E.4.2	Class B – Frequency – Measurement method	66
E.4.3	Class B – Frequency – Measurement uncertainty.....	66
E.4.4	Class B – Frequency – Measurement evaluation.....	67
E.4.5	Class B – Magnitude of the supply – Measurement method.....	67
E.4.6	Class B – Magnitude of the supply – Measurement uncertainty and measuring range.....	67
E.5	Class B – Flicker.....	67
E.5.1	General.....	67
E.5.2	Class B – Supply voltage dips and swells – Measurement method	67
E.6	Class B – Voltage interruptions	67
E.6.1	General.....	67
E.6.2	Class B – Supply voltage unbalance – Measurement method	67
E.6.3	Class B – Supply voltage unbalance –Uncertainty.....	67
E.6.4	Class B – Voltage harmonics – Measurement method.....	67
E.6.5	Class B –Voltage harmonics – Measurement uncertainty and range.....	67
E.6.6	Class B – Voltage interharmonics – Measurement method	68
E.6.7	Class B –Voltage interharmonics – Measurement uncertainty and range.....	68
E.6.8	Class B – Mains signalling voltage – Measurement method	68
E.6.9	Class B –Mains signalling voltage – Measurement uncertainty and range	68
E.6.10	Class B – Current – Measurement method	68
E.6.11	Class B – Current – Measurement uncertainty and range.....	68
Bibliography	69
Figure 1	– Measurement chain.....	17
Figure 2	– Synchronization of aggregation intervals for Class A	19
Figure 3	– Synchronization of aggregation intervals for Class S: parameters for which gaps are not permitted	20
Figure 4	– Synchronization of aggregation intervals for Class S: parameters for which gaps are permitted (see 4.5.2)	20
Figure 5	– Example of supply voltage unbalance uncertainty	28
Figure 6	– RVC event: example of a change in r.m.s voltage that results in an RVC event	33

Figure 7 – Not an RVC event: example of a change in r.m.s voltage that does not result in an RVC event because the dip threshold is exceeded 34

Figure A.1 – Frequency spectrum of typical representative transient test waveforms 45

Table 1 – Summary of requirements (see subclauses for actual requirements) 37

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

ELECTROMAGNETIC COMPATIBILITY (EMC) –

**Part 4-30: Testing and measurement techniques –
Power quality measurement methods**

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as “IEC Publication(s)”). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
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This consolidated version of the official IEC Standard and its amendment has been prepared for user convenience.

IEC 61000-4-30 edition 3.1 contains the third edition (2015-02) [documents 77A/873/FDIS and 77A/378/RVD] and its corrigendum (2016-12), and its amendment 1 (2021-03) [documents 77A/1080/CDV and 77A/1092/RVC].

This Final version does not show where the technical content is modified by amendment 1. A separate Redline version with all changes highlighted is available in this publication.

International Standard IEC 61000-4-30 has been prepared by subcommittee 77A: EMC – Low-frequency phenomena, of IEC technical committee 77: Electromagnetic compatibility.

This standard forms part 4-30 of IEC 61000. It has the status of a basic EMC publication in accordance with IEC Guide 107.

This third edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) the measurement method for current, previously informative, is now normative with some changes;
- b) the measurement method for RVC (rapid voltage change) has been added;
- c) the measurement method for conducted emissions in the 2 kHz to 150 kHz range has been added in informative Annex C;
- d) underdeviation and overdeviation parameters are moved to informative Annex D;
- e) Class A and Class S measurement methods are defined and clarified, while Class B is moved to informative Annex E and considered for future removal;
- f) measurement methods continue in this standard, but responsibility for influence quantities, performance, and test procedures are transferred to IEC 6286-2.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 61000 series, published under the general title *Electromagnetic compatibility (EMC)*, can be found on the IEC web site.

The committee has decided that the contents of the base publication and its amendment will remain unchanged until the stability date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

IMPORTANT: The 'colour inside' logo on the cover page of this publication indicates that it contains colours which are considered to be useful for the correct understanding of its contents. Users should therefore print this document using a colour printer.

INTRODUCTION

IEC 61000 is published in separate parts according to the following structure:

Part 1: General

General considerations (introduction, fundamental principles)
Definitions, terminology

Part 2: Environment

Description of the environment
Classification of the environment
Compatibility levels

Part 3: Limits

Emission limits
Immunity limits (in so far as they do not fall under the responsibility of the product committees)

Part 4: Testing and measurement techniques

Measurement techniques
Testing techniques

Part 5: Installation and mitigation guidelines

Installation guidelines
Mitigation methods and devices

Part 6: Generic standards

Part 9: Miscellaneous

Each part is further subdivided into several parts, published either as International Standards or as Technical Specifications or Technical Reports, some of which have already been published as sections. Others will be published with the part number followed by a dash and completed by a second number identifying the subdivision (example: 61000-6-1).

ELECTROMAGNETIC COMPATIBILITY (EMC) –

Part 4-30: Testing and measurement techniques – Power quality measurement methods

1 Scope

This part of IEC 61000-4 defines the methods for measurement and interpretation of results for power quality parameters in a.c. power supply systems with a declared fundamental frequency of 50 Hz or 60 Hz.

Measurement methods are described for each relevant parameter in terms that give reliable and repeatable results, regardless of the method's implementation. This standard addresses measurement methods for in-situ measurements.

Measurement of parameters covered by this standard is limited to conducted phenomena in power systems. The power quality parameters considered in this standard are power frequency, magnitude of the supply voltage, flicker, supply voltage dips and swells, voltage interruptions, transient voltages, supply voltage unbalance, voltage harmonics and interharmonics, mains signalling on the supply voltage, rapid voltage changes, and current measurements. Emissions in the 2 kHz to 150 kHz range are considered in Annex C (informative), and over- and underdeviations are considered in Annex D (informative). Depending on the purpose of the measurement, all or a subset of the phenomena on this list may be measured.

NOTE 1 Test methods for verifying compliance with this standard can be found in IEC 62586-2.

NOTE 2 The effects of transducers inserted between the power system and the instrument are acknowledged but not addressed in detail in this standard. Guidance about effects of transducers can be found IEC TR 61869-103.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60050 (all parts), *International Electrotechnical Vocabulary (IEV)* (available at www.electropedia.org)

IEC 61000-2-4, *Electromagnetic compatibility (EMC) – Part 2-4: Environment – Compatibility levels in industrial plants for low-frequency conducted disturbances*

IEC 61000-3-8, *Electromagnetic compatibility (EMC) – Part 3: Limits – Section 8: Signalling on low-voltage electrical installations – Emission levels, frequency bands and electromagnetic disturbance levels*

IEC 61000-4-7:2002, *Electromagnetic compatibility (EMC) – Part 4-7: Testing and measurement techniques – General guide on harmonics and interharmonics measurements and instrumentation, for power supply systems and equipment connected thereto*
IEC 61000-4-7:2002/AMD1:2008

IEC 61000-4-15:2010, *Electromagnetic compatibility (EMC) – Part 4-15: Testing and measurement techniques – Flickermeter – Functional and design specifications*